

-55V P-Channel MOSFET

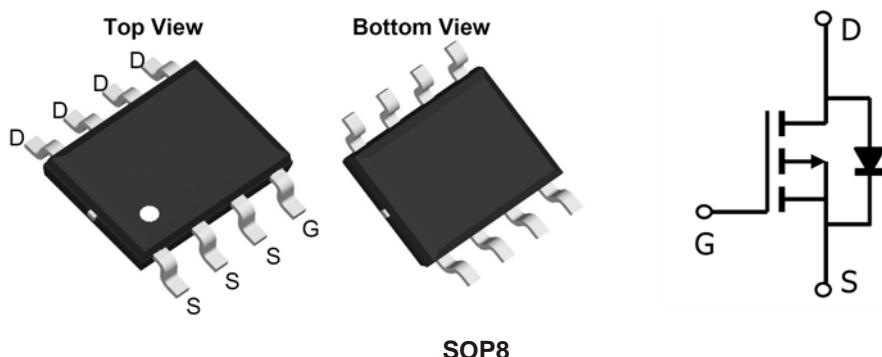
- Features

-55V/5.8A ,
 $R_{DS(ON)} < 35m\Omega$ @ $V_{GS} = -10V$
 $R_{DS(ON)} < 50m\Omega$ @ $V_{GS} = -4.5V$
 Lead Free Available (RoHS Compliant)

- General Description

The FS2241 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. this device is well suited for high current load applications.

- Pin Configuration



- Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	-55	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current $T_A=25^\circ C$	I_D	5.8	A
$T_A=70^\circ C$	I_D	4.7	
Pulsed Drain Current ^C	I_{DM}	25	
Avalanche Current ^C	I_{AS}, I_{AR}	8	
Avalanche energy $L=0.1mH$ ^C	E_{AS}, E_{AR}	18	mJ
Power Dissipation ^B $T_A=25^\circ C$	P_D	3.1	W
$T_A=70^\circ C$	P_D	2	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics					
Parameter	Symbol	Typ	Max	Units	
Maximum Junction-to-Ambient ^A $t \leq 10s$	$R_{\theta JA}$	31	40	°C/W	
Maximum Junction-to-Ambient ^{A,D}		59	75		
Maximum Junction-to-Lead	$R_{\theta JL}$	16	24		

● Electrical Characteristics ($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ	Max	Units	
STATIC PARAMETERS								
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$		-55			V	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-55\text{V}, V_{GS}=0$	$T_A=25^\circ\text{C}$		-0.002	-1	uA	
			$T_A=55^\circ\text{C}$			-5		
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$				± 0.1		
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$		-0.8		-2.5	V	
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=-10\text{V}, V_{DS}=-5\text{V}$		5.8			A	
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=-10\text{V}, I_D=-10\text{A}$	$T_A=25^\circ\text{C}$		30	40	mΩ	
			$T_A=125^\circ\text{C}$		50			
		$V_{GS}=-4.5\text{V}, I_D=-8\text{A}$			45	50		
g_{FS}	Forward Trans conductance	$V_{DS}=-5\text{V}, I_D=-12\text{A}$			13.4		S	
V_{SD}	Diode Forward Voltage	$I_S=-1\text{A}, V_{GS}=0\text{V}$			-0.75	-1.2	V	
I_S	Maximum Body-Diode Continuous Current					-2.5	A	
DYNAMIC PARAMETERS								
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=-30\text{V}, f=1\text{MHz}$			980	1170	pF	
C_{oss}	Output Capacitance				110	127		
C_{rss}	Reverse Transfer Capacitance				45	63		
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$			6	10	Ω	
SWITCHING PARAMETERS								
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=-10\text{V}, V_{DS}=-30\text{V}, I_D=-12\text{A}$			15		nC	
					7.5			
Q_{gs}	Gate Source Charge				2.5			
					3			
$t_{\text{D(on)}}$	Turn-On Delay Time	$V_{GS}=-10\text{V}, V_{DS}=-30\text{V}, R_L=2.5\Omega, R_{\text{GEN}}=3\Omega$			8		ns	
					9.5			
$t_{\text{D(off)}}$	Turn-Off Delay Time				19			
					10			
t_{f}	Turn-Off Fall Time				25	35		
t_{rr}	Body Diode Reverse Recovery Time	$I_F=-12\text{A}, dI/dt=100\text{A}/\mu\text{s}$			27		nC	
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=-12\text{A}, dI/dt=100\text{A}/\mu\text{s}$						

A: The value of R_{BSA} is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on R_{BSA} and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$.

D. The R_{BSA} is the sum of the thermal impedance from junction to case R_{BJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using $<300\ \mu\text{s}$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$.

G. The maximum current rating is limited by bond-wires.

H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

*This device is guaranteed green after data code 8X11 (Sep 1ST 2008).

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

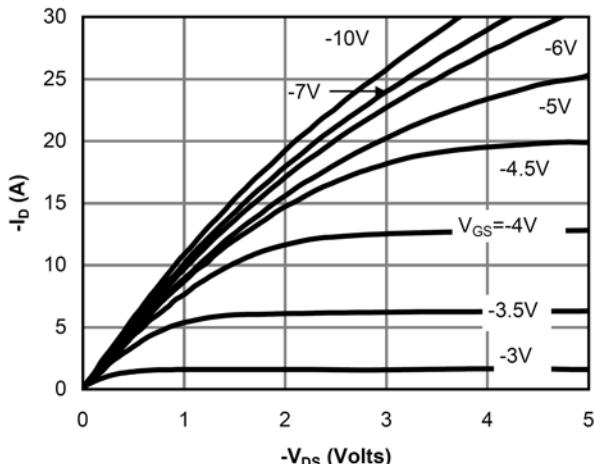


Fig 1: On-Region Characteristics

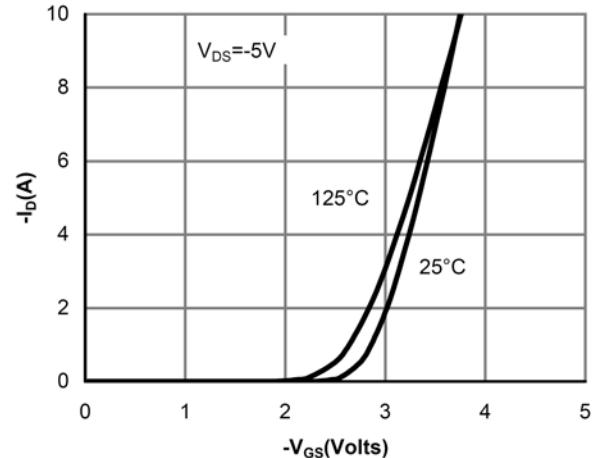


Figure 2: Transfer Characteristics

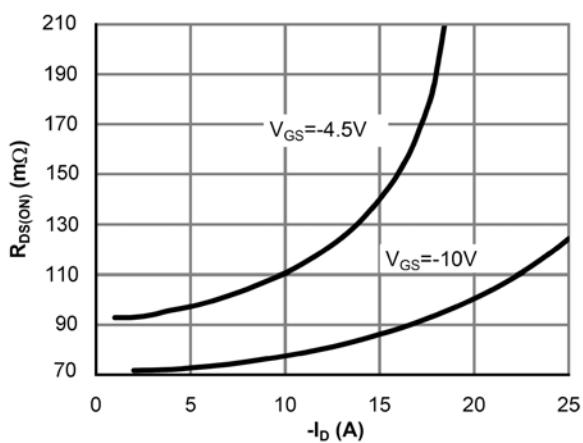


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

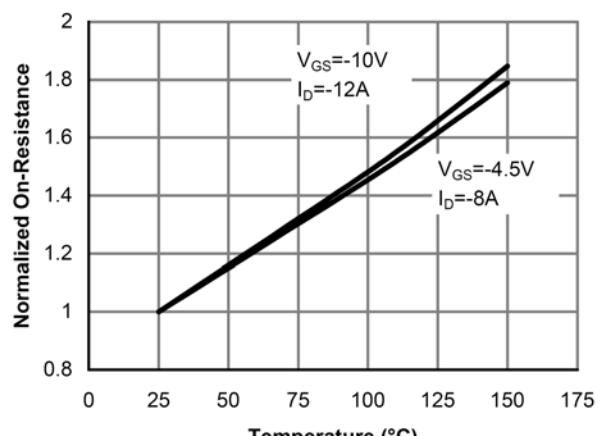


Figure 4: On-Resistance vs. Junction Temperature

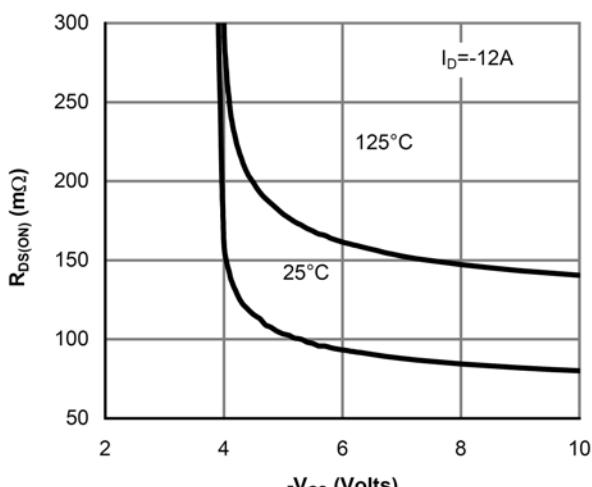


Figure 5: On-Resistance vs. Gate-Source Voltage

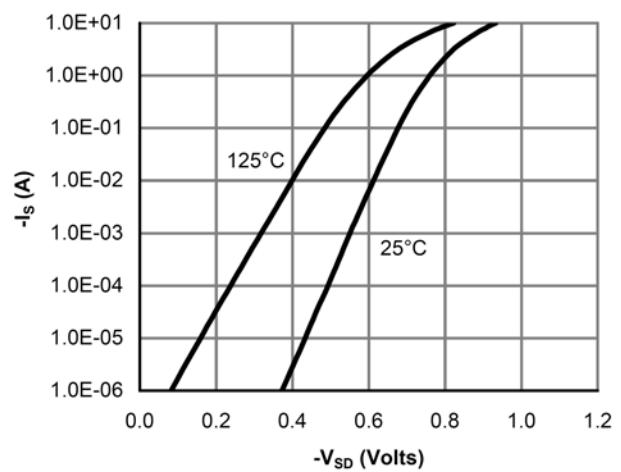


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

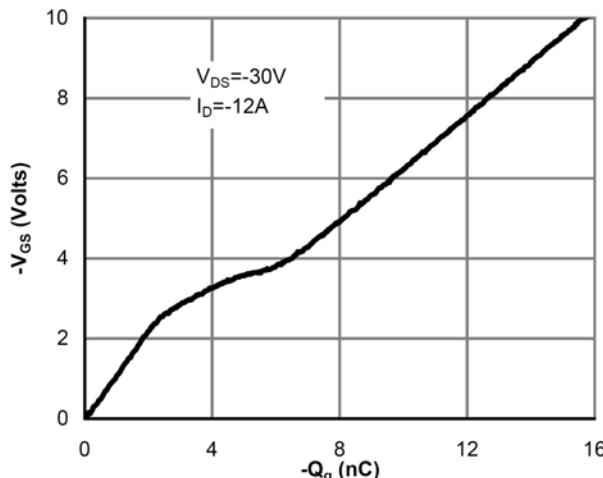


Figure 7: Gate-Charge Characteristics

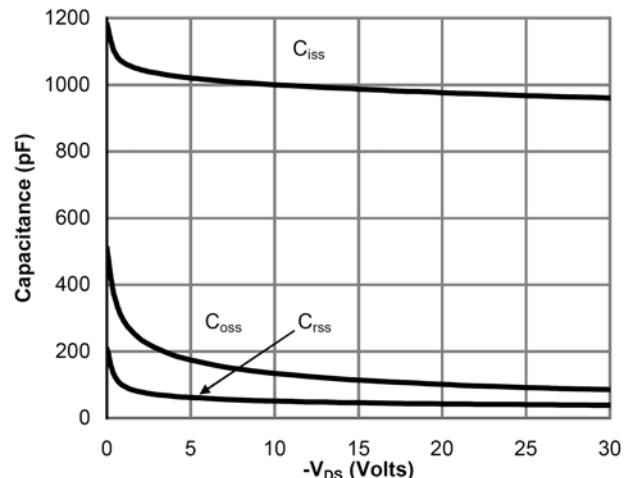


Figure 8: Capacitance Characteristics

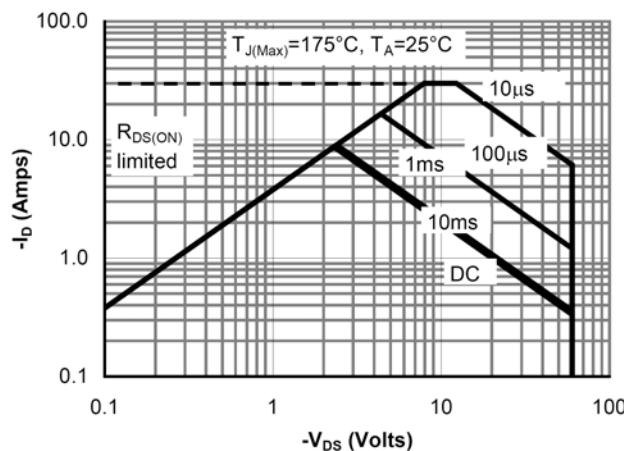


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

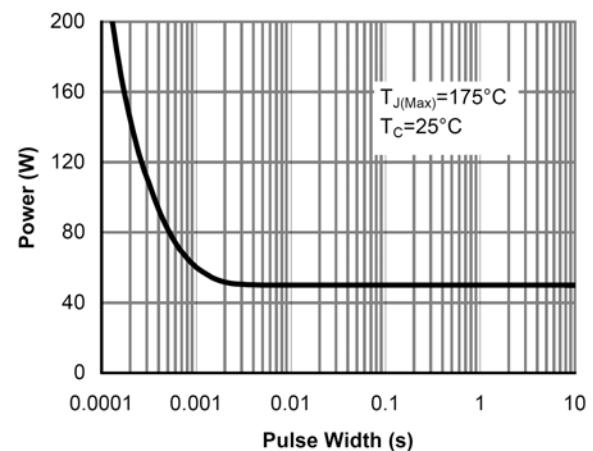


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

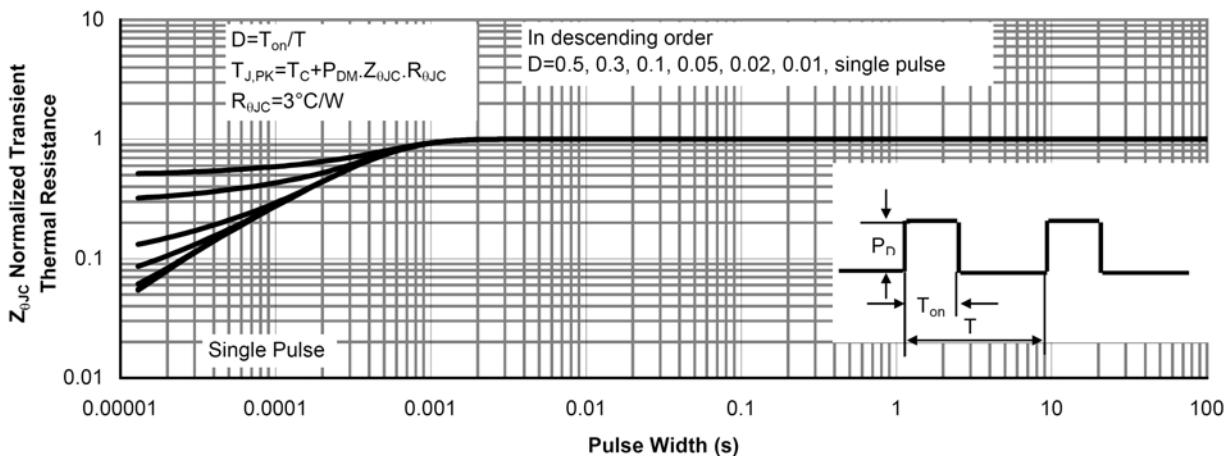


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

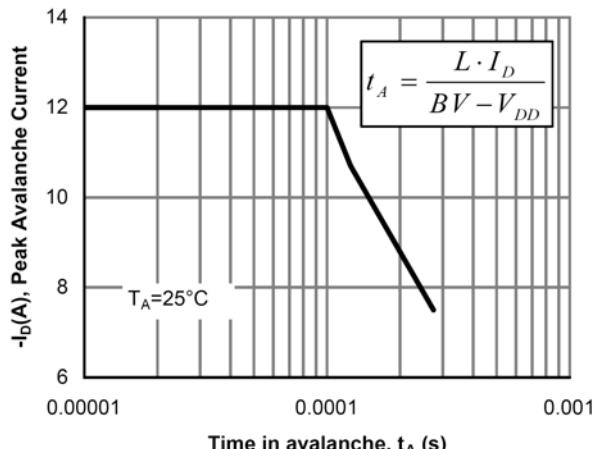


Figure 12: Single Pulse Avalanche capability

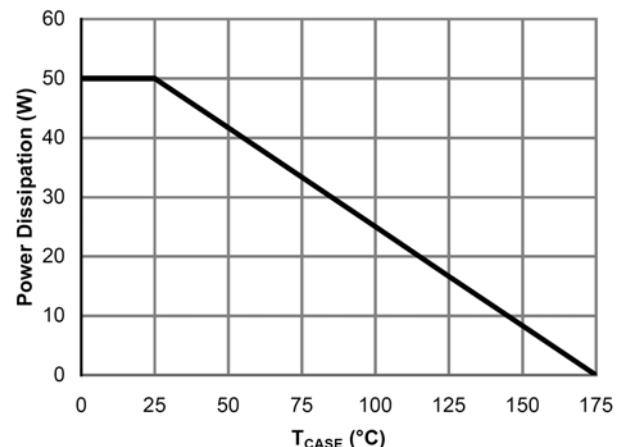


Figure 13: Power De-rating (Note B)

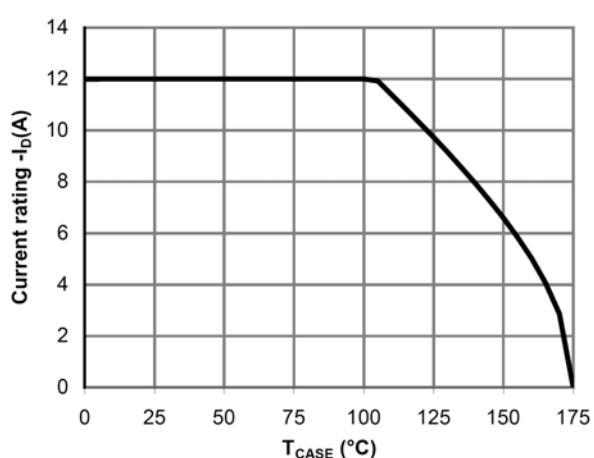


Figure 14: Current De-rating (Note B)

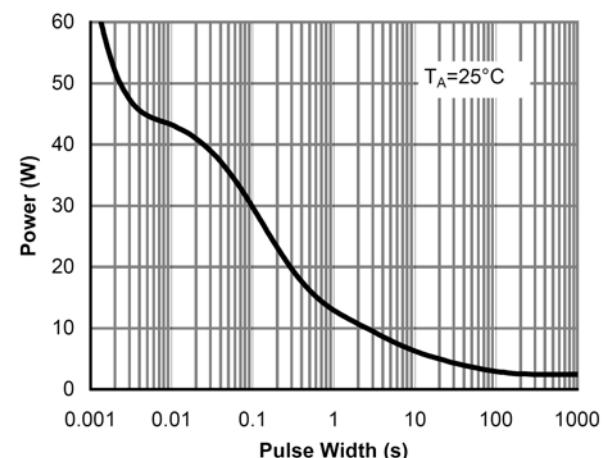


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

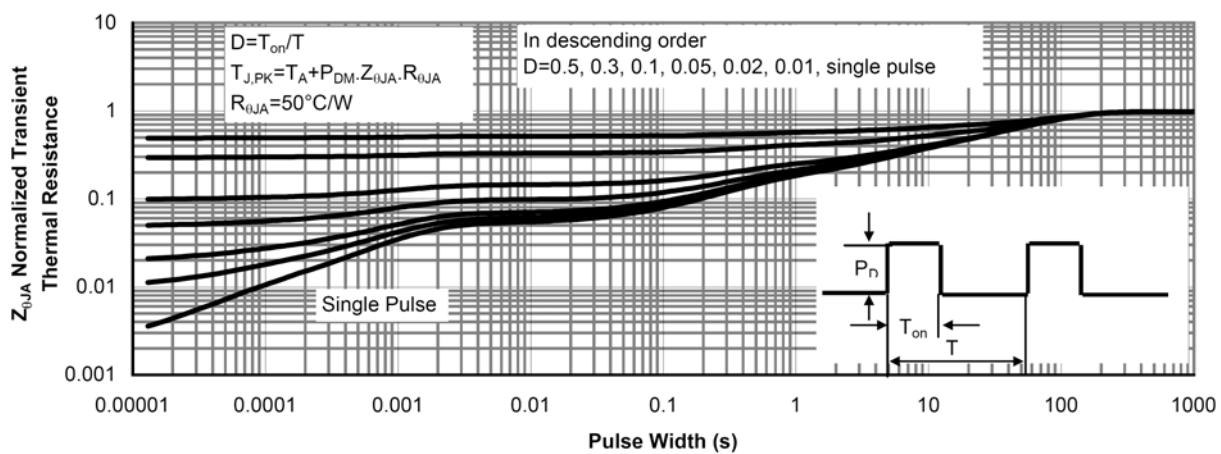
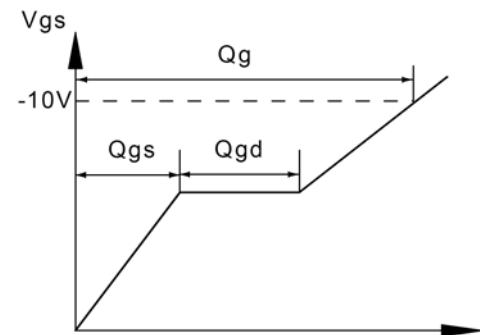
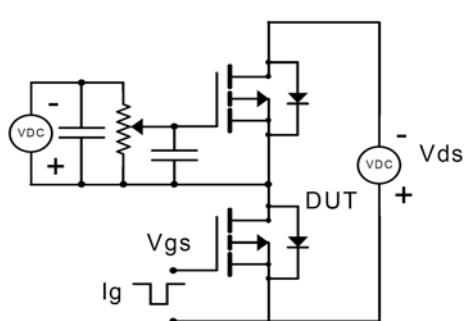


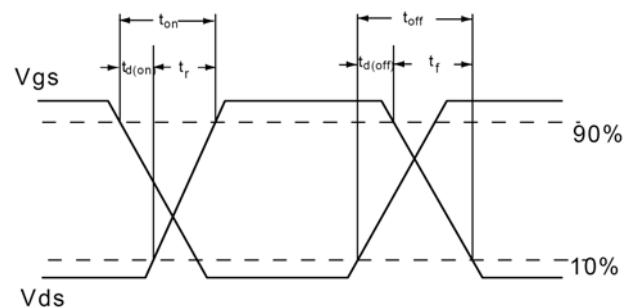
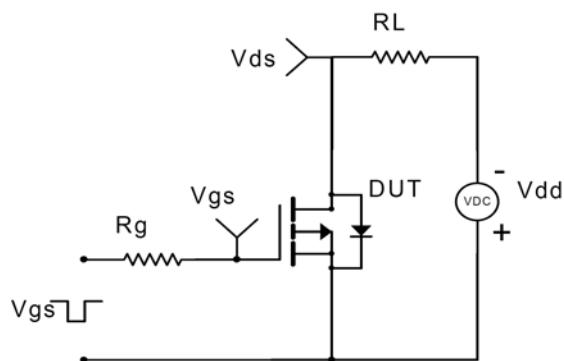
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

FS2241

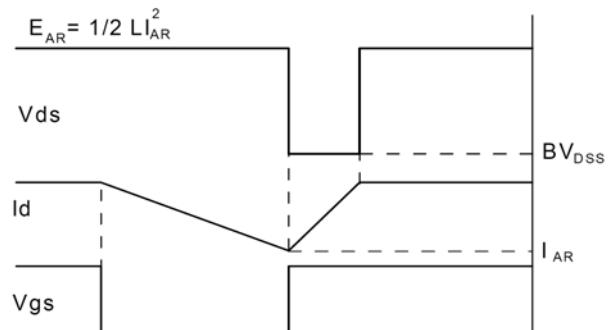
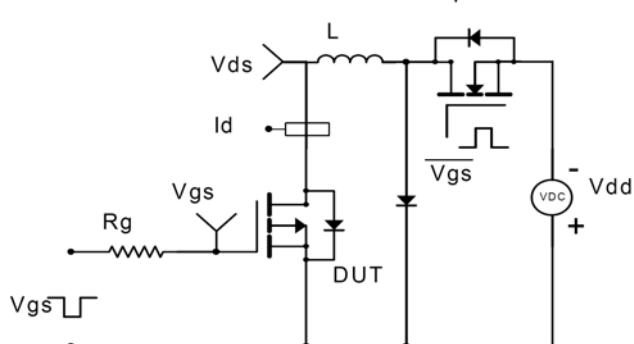
Gate Charge Test Circuit & Waveform



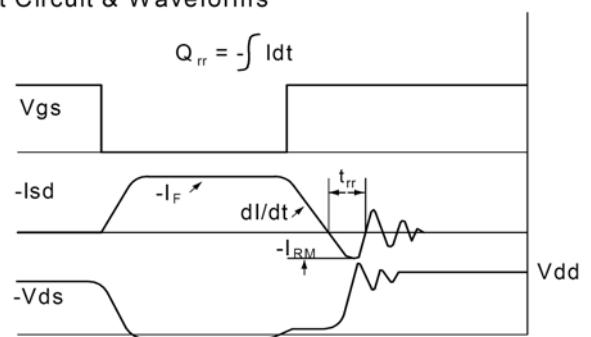
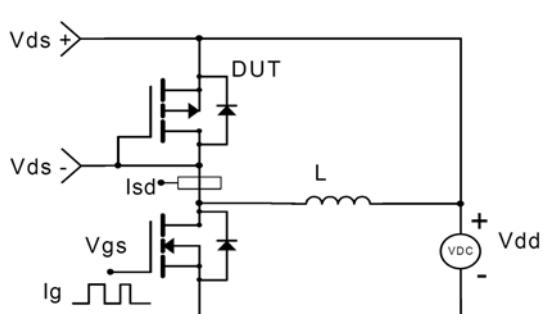
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



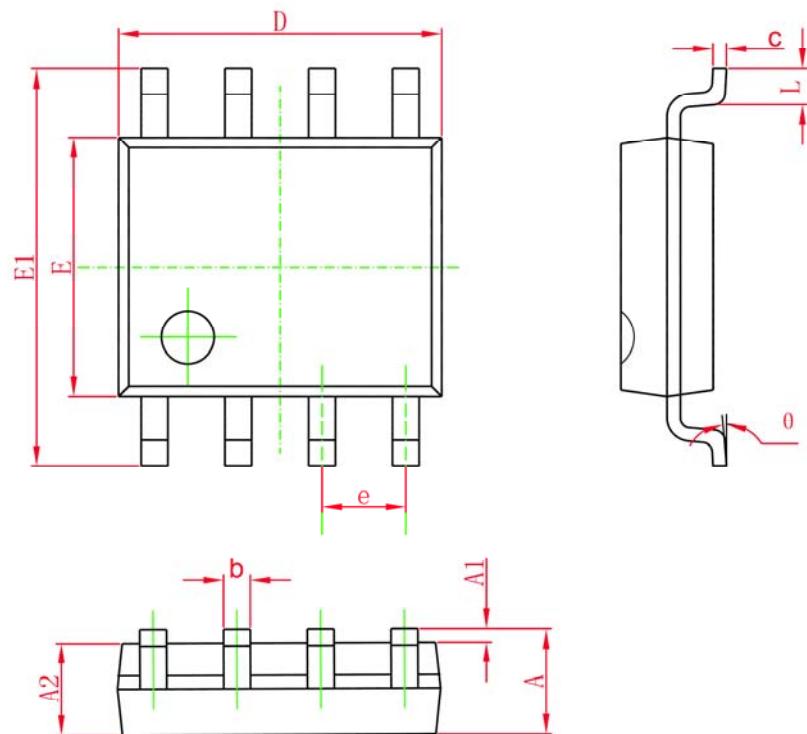
Diode Recovery Test Circuit & Waveforms



FS2241

● Package Information

SOP8 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°